

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/073,910 | Applicant(s)/Patent Under Reexamination TANAKO, YOSHINOBU | |
| | Examiner Hemang Sanghavi | Art Unit 2883 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-4,973,126 | 11-1990 | Degani et al. | 385/55 |
| | B | US-5,134,673 | 07-1992 | Stephenson et al. | 385/56 |
| | C | US-6,193,421 | 02-2001 | Tamekuni et al. | 385/65 |
| | D | US-6,254,280 | 07-2001 | Hubbauer et al. | 385/65 |
| | E | US-5,963,699 | 10-1999 | Tanaka et al. | 385/97 |
| | F | US-4,662,713 | 05-1987 | Davies et al. | 385/73 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.